

#### 30V N-CHANNEL ENHANCEMENT MODE MOSFET

# **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> Max T <sub>A</sub> = +25°C
00)/	15mΩ @ V <sub>GS</sub> = 10V	9.3A
30V	$20m\Omega$ @ $V_{GS} = 4.5V$	8.1A

#### **Features**

- 0.6mm Profile Ideal for Low Profile Applications
- PCB Footprint of 4mm<sup>2</sup>
- Low Gate Threshold Voltage
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

## **Description**

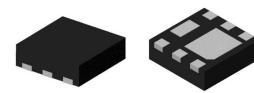
This MOSFET is designed to minimize the on-state resistance (R<sub>DS(ON)</sub>), yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Battery Management Application
- Power Management Functions
- DC-DC Converters

#### **Mechanical Data**

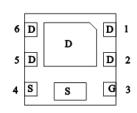
- Case: U-DFN2020-6 (Type F)
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.007 grams (Approximate)

#### U-DFN2020-6 (Type F)

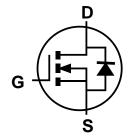


Top View

**Bottom View** 



Pin Out Bottom View



Internal Schematic

#### **Ordering Information** (Note 4)

Part Number	Case	Packaging
DMN3021LFDF-7	U-DFN2020-6 (Type F)	3,000/Tape & Reel
DMN3021LFDF-13	U-DFN2020-6 (Type F)	10,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

# **Marking Information**



F2 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: D = 2016) M = Month (ex: 9 = September)

Date Code Key

Year	2016		2017	2018		2019	2020		2021	2022		2023
Code	D		Е	F		G	Н		I	J		K
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# **Maximum Ratings** $(@T_A = +25^{\circ}C, \text{ unless otherwise specified.})$

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	$V_{DSS}$	30	V		
Gate-Source Voltage	$V_{GSS}$	±20	V		
Continuous Drain Current (Note 6) V 40V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	9.3 7.5	А
Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V	t<5s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	11.8 9.4	А
Pulsed Drain Current (380µs Pulse, Duty Cycle = 1%	I <sub>DM</sub>	50	Α		
Maximum Continuous Drain-Source Diode Forward (	Is	1.8	Α		
Avalanche Current (Note 7) L = 0.1mH	I <sub>AS</sub>	18	А		
Repetitive Avalanche Energy (Note 7) L = 0.1mH	E <sub>AS</sub>	16	mJ		

# **Thermal Characteristics**

Characteristic	Symbol	Value	Unit		
Total Power Dissipation (Note 5)	$T_A = +25$ °C	р	0.73	w	
Total Power Dissipation (Note 3)	$T_A = +70$ °C	$P_{D}$	0.47	VV	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	D	174	°C/W	
Thermal Resistance, Junction to Ambient (Note 5)	t < 5s	$R_{\Theta JA}$	112	C/VV	
Total Power Dissipation (Note 6)	$T_A = +25$ °C	Pn	2.03	W	
Total Power Dissipation (Note 6)	$T_A = +70$ °C	PD	1.30		
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	D	64	°C/W	
Thermal Resistance, Junction to Ambient (Note 6)	t < 5s	$R_{\Theta JA}$	40		
Thermal Resistance, Junction to Case (Note 6)	$R_{\Theta JC}$	13			
Operating and Storage Temperature Range		T <sub>J,</sub> T <sub>STG</sub>	-55 to +150	°C	

# **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	-	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1.0	_	2.2	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	Б		_	15	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 7A
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	_	20	11177	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 7A
Diode Forward Voltage	V <sub>SD</sub>	_	0.8	1.2	V	$V_{GS} = 0V, I_S = 2.2A$
DYNAMIC CHARACTERISTICS (Note 9)						·
Input Capacitance	C <sub>ISS</sub>	_	706	_		$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz
Output Capacitance	Coss	_	112	_	pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>	_	81	_		1 = 1.0IVII IZ
Gate Resistance	R <sub>G</sub>	_	2.6	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_{G}$	_	14	_		
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_{G}$	_	6.7	_		\\\\ 45\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
Gate-Source Charge	Q <sub>GS</sub>	_	1.9	_	nC	$V_{DS} = 15V, I_{D} = 5A$
Gate-Drain Charge	$Q_{GD}$	_	2.5	_		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	5.4	_		
Turn-On Rise Time	t <sub>R</sub>	_	6.8	_	1	$V_{DS} = 15V, V_{GS} = 4.5V,$
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	9.7	_	ns	$R_G = 1.7\Omega$ , $I_D = 5A$
Turn-Off Fall Time	t <sub>F</sub>	_	4.7	_		

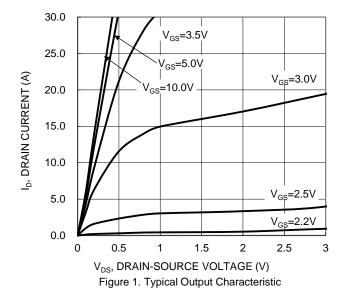
5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

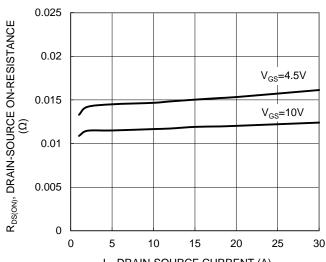
<sup>6.</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate.

<sup>7.</sup>  $I_{AS}$  and  $E_{AS}$  rating are based on low frequency and duty cycles to keep  $T_{J} = +25^{\circ}C$ .

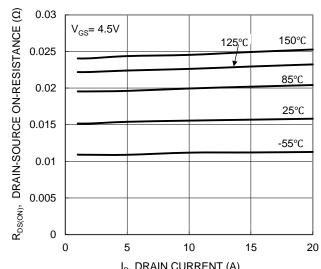
Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.



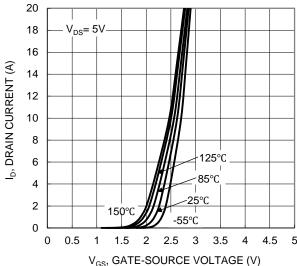




I<sub>D</sub>, DRAIN-SOURCE CURRENT (A) Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage



I<sub>D</sub>, DRAIN CURRENT (A) Figure 5. Typical On-Resistance vs. Drain Current and Temperature



V<sub>GS</sub>, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic

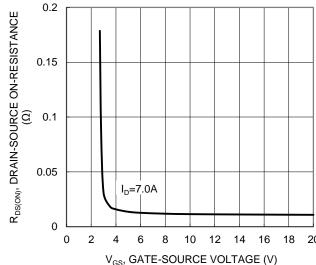
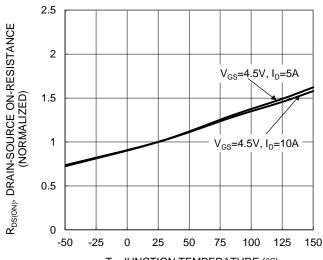


Figure 4. Typical Transfer Characteristic



T<sub>J</sub>, JUNCTION TEMPERATURE (°C) Figure 6. On-Resistance Variation with Temperature





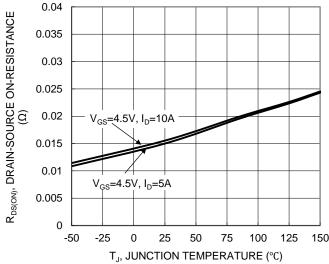
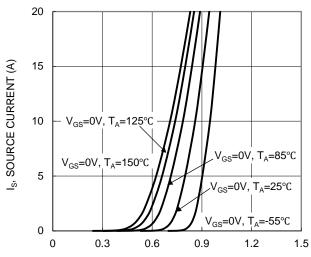
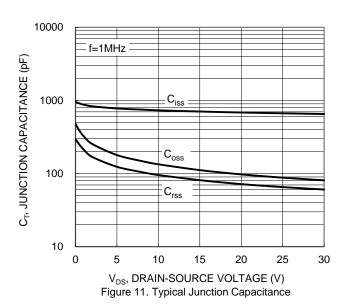


Figure 7. On-Resistance Variation with Temperature



V<sub>SD</sub>, SOURCE-DRAIN VOLTAGE (V) Figure 9. Diode Forward Voltage vs. Current



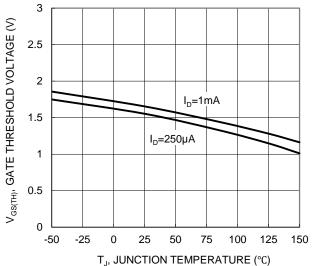
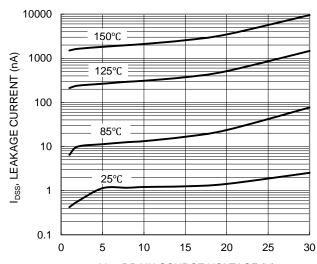


Figure 8. Gate Threshold Variation vs. Junction
Temperature



V<sub>DS</sub>, DRAIN-SOURCE VOLTAGE (V) Figure 10. Typical Drain-Source Leakage Current vs. Voltage

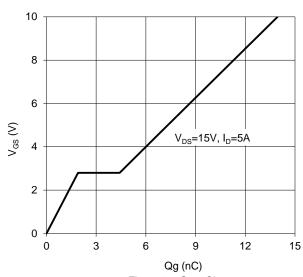
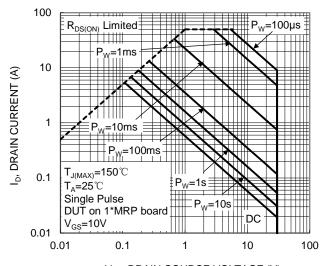


Figure 12. Gate Charge





 $V_{DS}$ , DRAIN-SOURCE VOLTAGE (V) Figure 13. SOA, Safe Operation Area

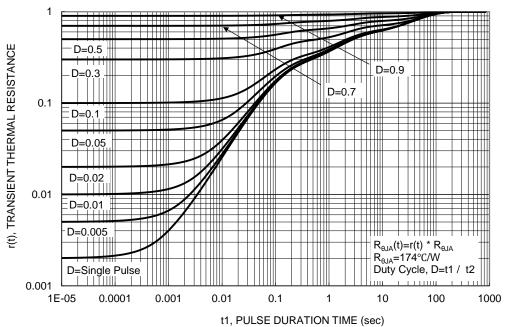


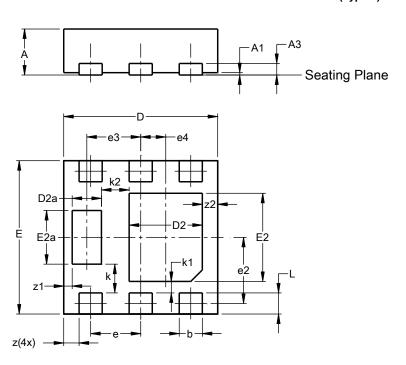
Figure 14. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### U-DFN2020-6 (Type F)

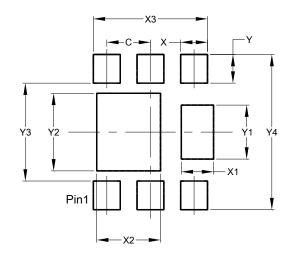


U-DFN2020-6										
Dim	(Type F)  Dim Min Max Typ									
			1 yp							
Α	0.57	0.63	0.60							
A1	0.00 0.05 0.03									
A3	-	-	0.15							
b	0.25	0.35	0.30							
D	1.95	2.05	2.00							
D2	0.85	1.05	0.95							
D2a	0.33	0.43	0.38							
Е	1.95	2.05	2.00							
E2	1.05	1.25	1.15							
E2a	0.65	0.75	0.70							
е	0.65 BSC									
e2		).863 BS	SC							
е3		0.70 BS	С							
e4	0.325 BSC									
k	0.37 BSC									
k1	0.15 BSC									
k2	0.36 BSC									
L	0.225 0.325 0.275									
Z	0.20 BSC									
<b>z</b> 1	0.110 BSC									
z2	0.20 BSC									
All Dimensions in mm										

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### U-DFN2020-6 (Type F)



Dimensions	Value
2	(in mm)
С	0.650
X	0.400
X1	0.480
X2	0.950
Х3	1.700
Y	0.425
Y1	0.800
Y2	1.150
Y3	1.450
Y4	2.300



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